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Electronic Supplementary Information

Strong interlayer coupling and unusual antisite defects mediated p-type conductivity in GeP_x ($x = 1, 2$)

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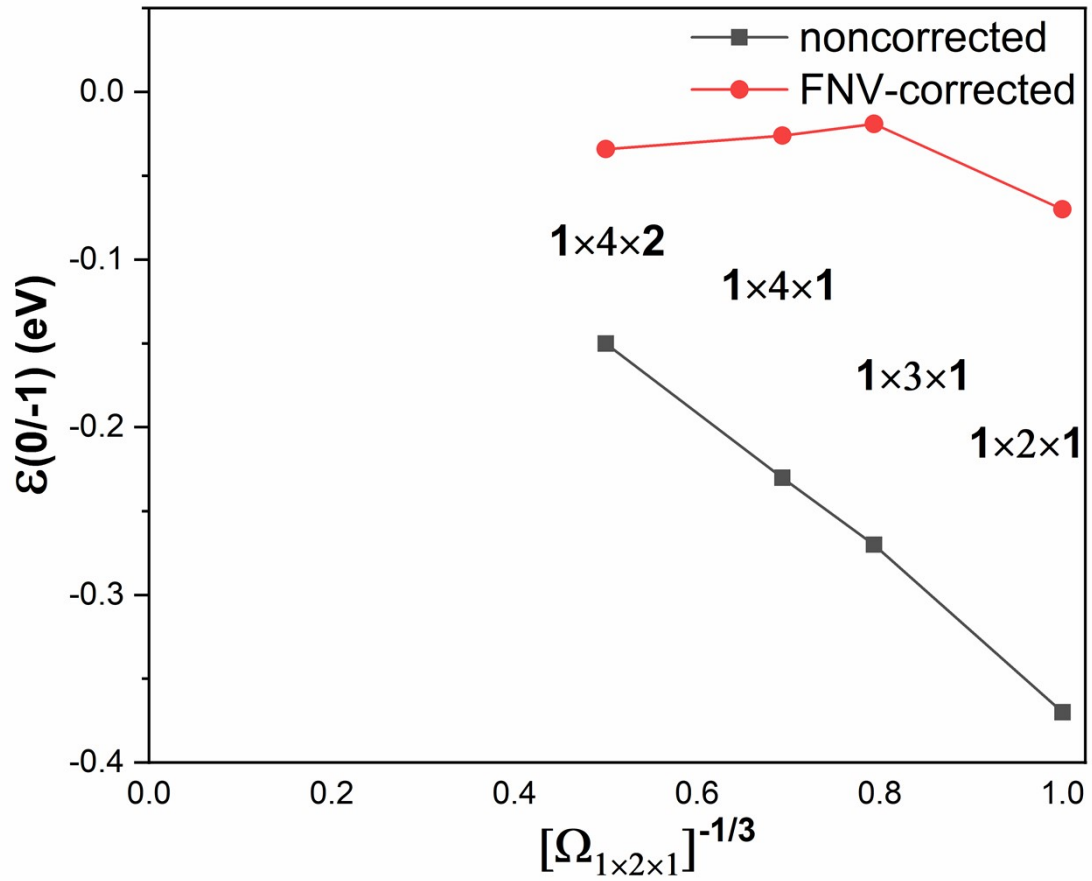


Figure S1. The transition energy level of P vacancy, $\epsilon(0/-1)$, calculated with varied volume Ω (in unit of volume of $1 \times 2 \times 1$ supercell, $\Omega_{1 \times 2 \times 1}$) of supercells in bulk GeP.

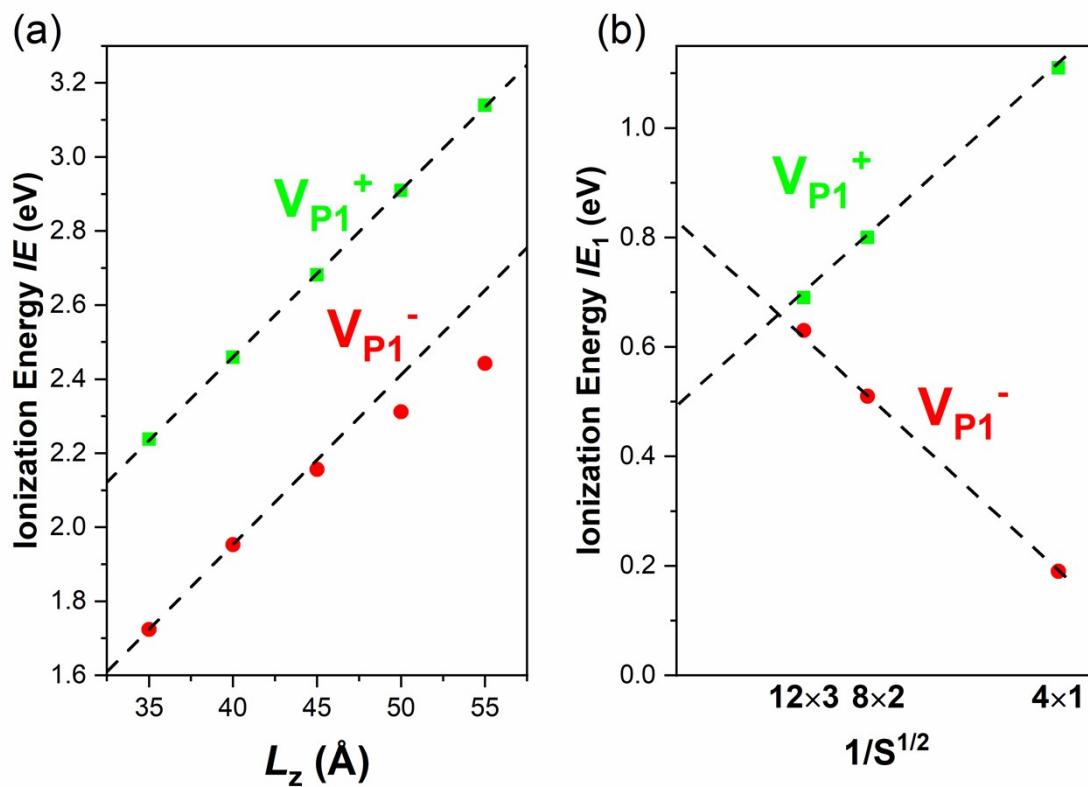


Figure S2. Transition energy level (ionization energy) $\epsilon(+1/0)$ and $\epsilon(0/-1)$ of P vacancy as a function of (a) the length of the slab in the z-direction and (b) $1/S^{1/2}$ (S: the lateral size of slab).

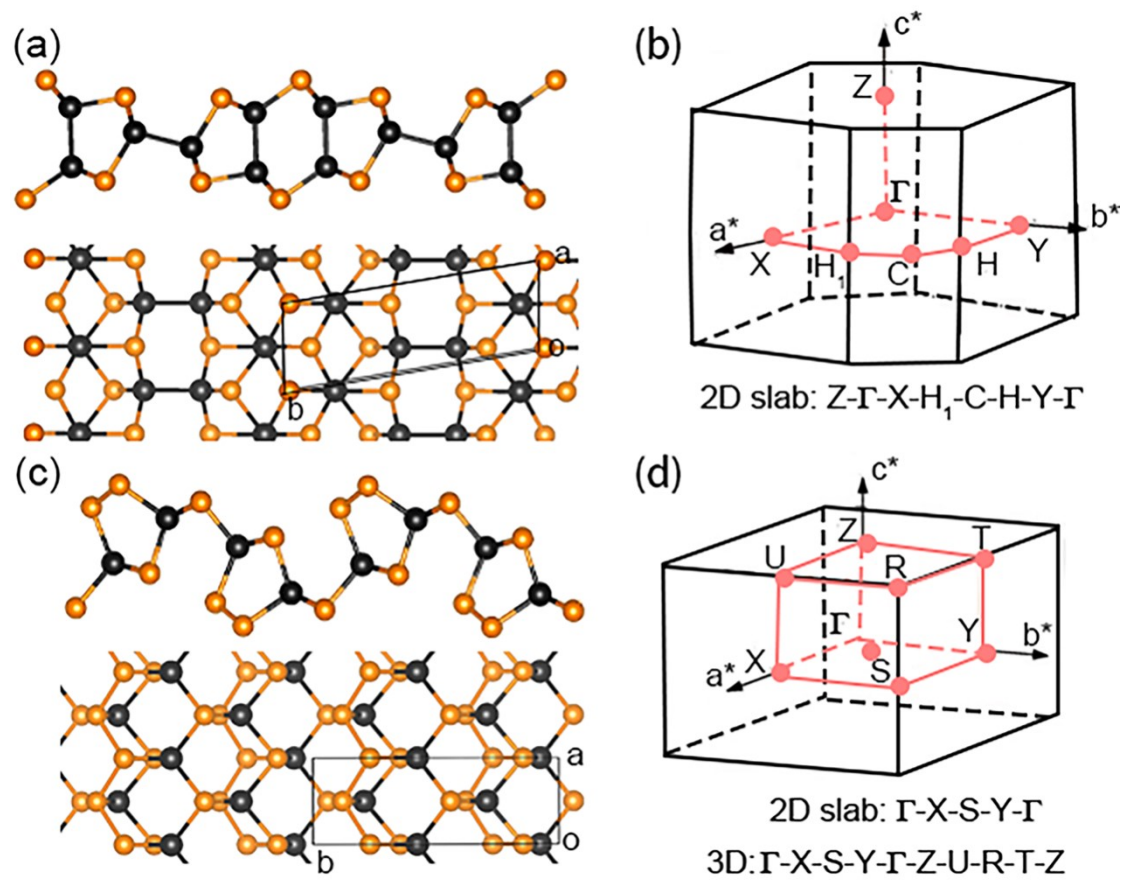


Figure S3. (a) Structures of 1L GeP and (b) high-symmetry path of k-points in the reciprocal space, (c) structures of 1L GeP₂ and (d) high-symmetry path of k-points in the reciprocal space.

Table S1. Theoretical lattice constants (a), bandgaps (E_g) of GeP and GeP₂ with experimental values or calculated results for comparison.

		a (Å)	b (Å)	c (Å)	β (°)	E_g (eV)		ΔE_g (eV)
						bulk	1L	$E_g^{1L} - E_g^{bulk}$
GeP	This work	15.36	3.71	9.31	79.28	1.07	2.39	1.32
	Theo. ¹⁰	15.86	3.70	9.33	79.24	0.94	2.31	1.37
	Exptl. ^{32,33}	15.14	3.64	9.19	78.90	0.9	2.3	1.4
GeP ₂	This work	3.57	10.18	14.35	90	1.65	2.01	0.36
	Theo. ³⁴	3.54	10.40	14.52	90	-	1.98	-

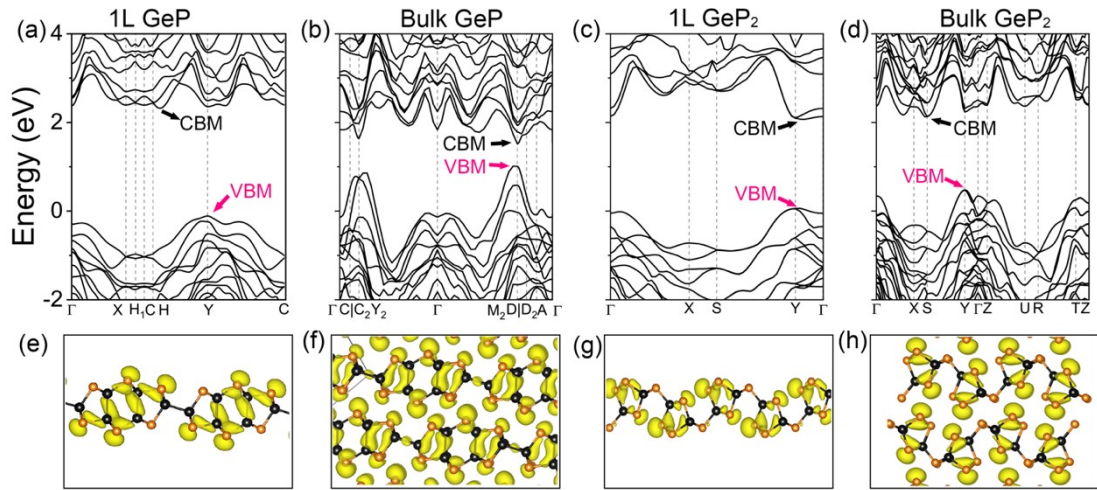


Figure S4. HSE06 calculated band structures and VBM partial charge densities of (a) 1L GeP, (b) bulk GeP, (c) 1L GeP₂ and (d) bulk GeP₂. Energy levels are aligned with respect to vacuum level, and the zero point of energy is situated at the Fermi level of 1L GeP.

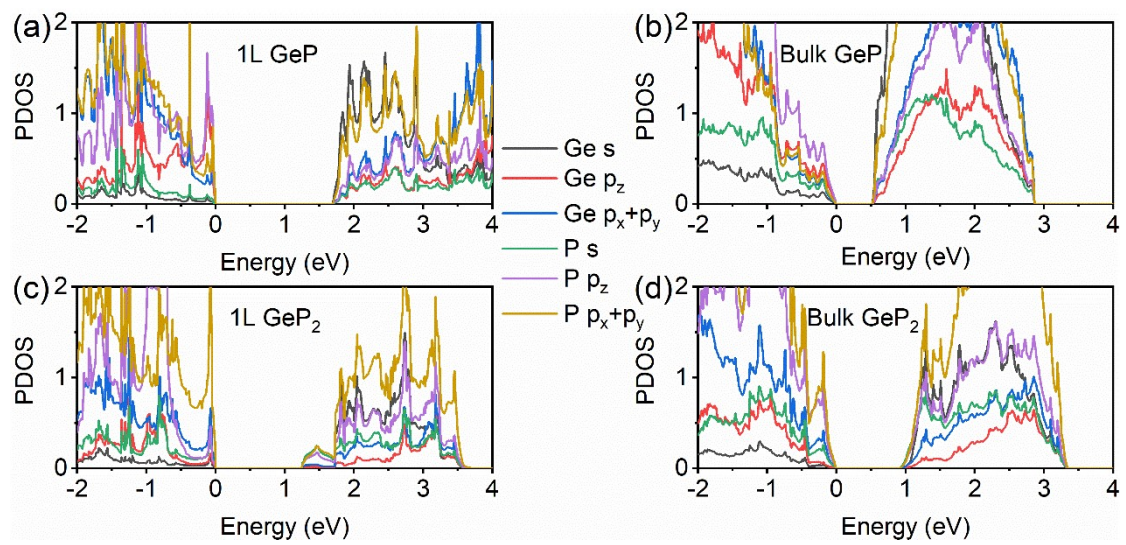


Figure S5. Partial density of states for (a, b) 1L and bulk GeP, respectively; (c, d) 1L and bulk GeP₂, respectively.

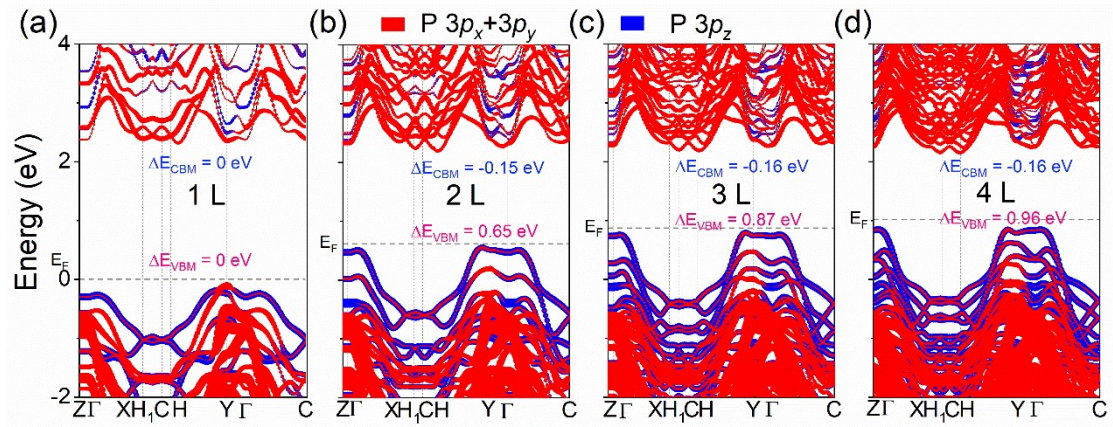


Figure S6. HSE06 calculated band structures of GeP of (a) monolayer (1L), (b) bilayer (2L), (c) trilayer (3L) and (d) quad-layer (4L), aligned based on the vacuum level (the Fermi level of 1L GeP is set as 0 eV).

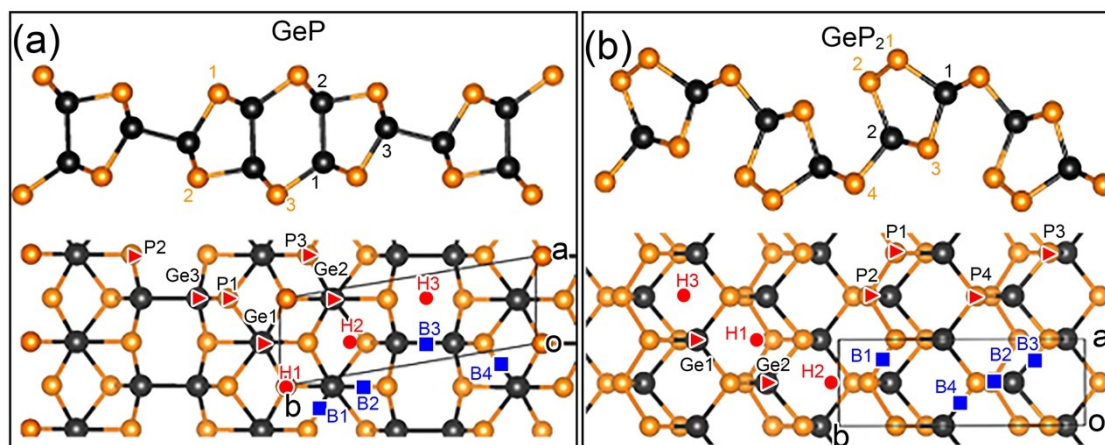


Figure S7. Schemes of sites for self-interstitials or adatoms in (a) GeP and (b) GeP₂.

Table S2. Relative energies of self-interstitials on different sites in GeP and GeP₂.

GeP			GeP ₂		
Sites	Energy (eV)		Sites	Energy (eV)	
	Ge _i	P _i		Ge _i	P _i
Ge1	0.27	-	Ge1	-	-
Ge2	0.24	-	Ge2	-	-
Ge3	0.20	-	P1	0.82	1.18
P1	-	0.29	P2	-	-
P2	-	0.45	P3	-	-
P3	-	0.30	P4	0.83	1.26
B1	0.31	-	B1	0	0
B2	0.31	0	B2	1.04	1.07
B3	-	0.97	B3	1.14	1.58
B4	-	0.40	B4	1.45	-
H1	0.35	0.44	H1	1.09	1.33
H2	0.09	0.34	H2	0.47	0.86
H3	0	0.31	H3	0.81	-
In	0.73	0.96	In	-	-

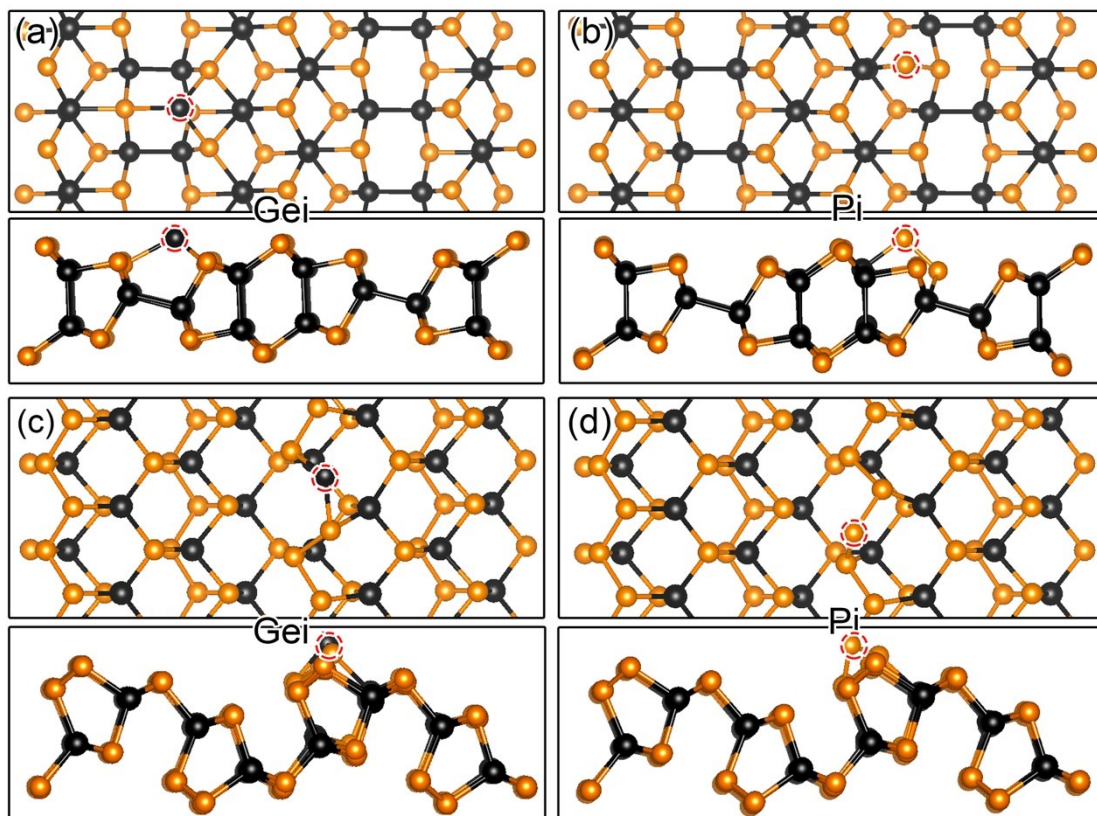


Figure S8. Atomic configurations of the most favorable sites for self-interstitials (a)

Ge_i in GeP , (b) P_i in GeP , (c) Ge_i in GeP_2 , and (d) P_i in GeP_2 .

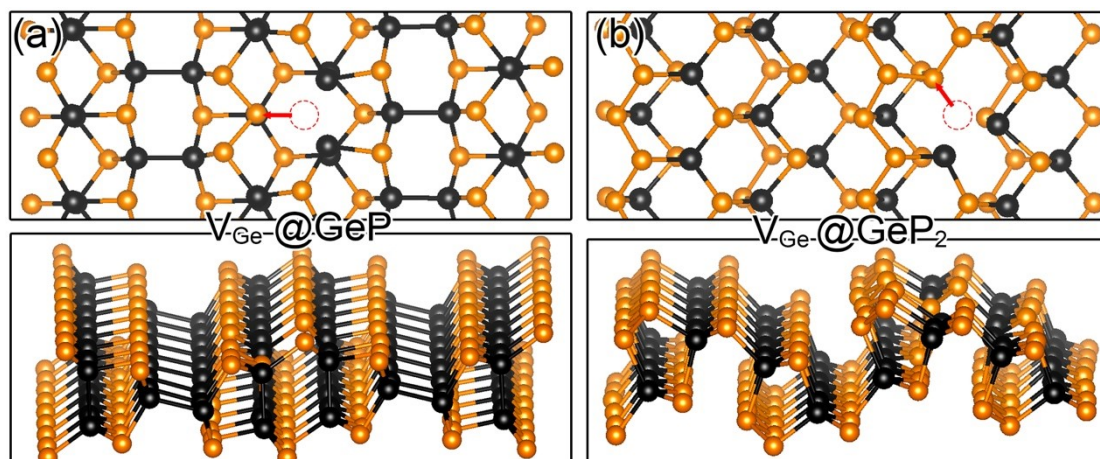


Figure S9. Atomic configurations of Ge vacancy (V_{Ge}) in (a) GeP and (b) GeP₂.

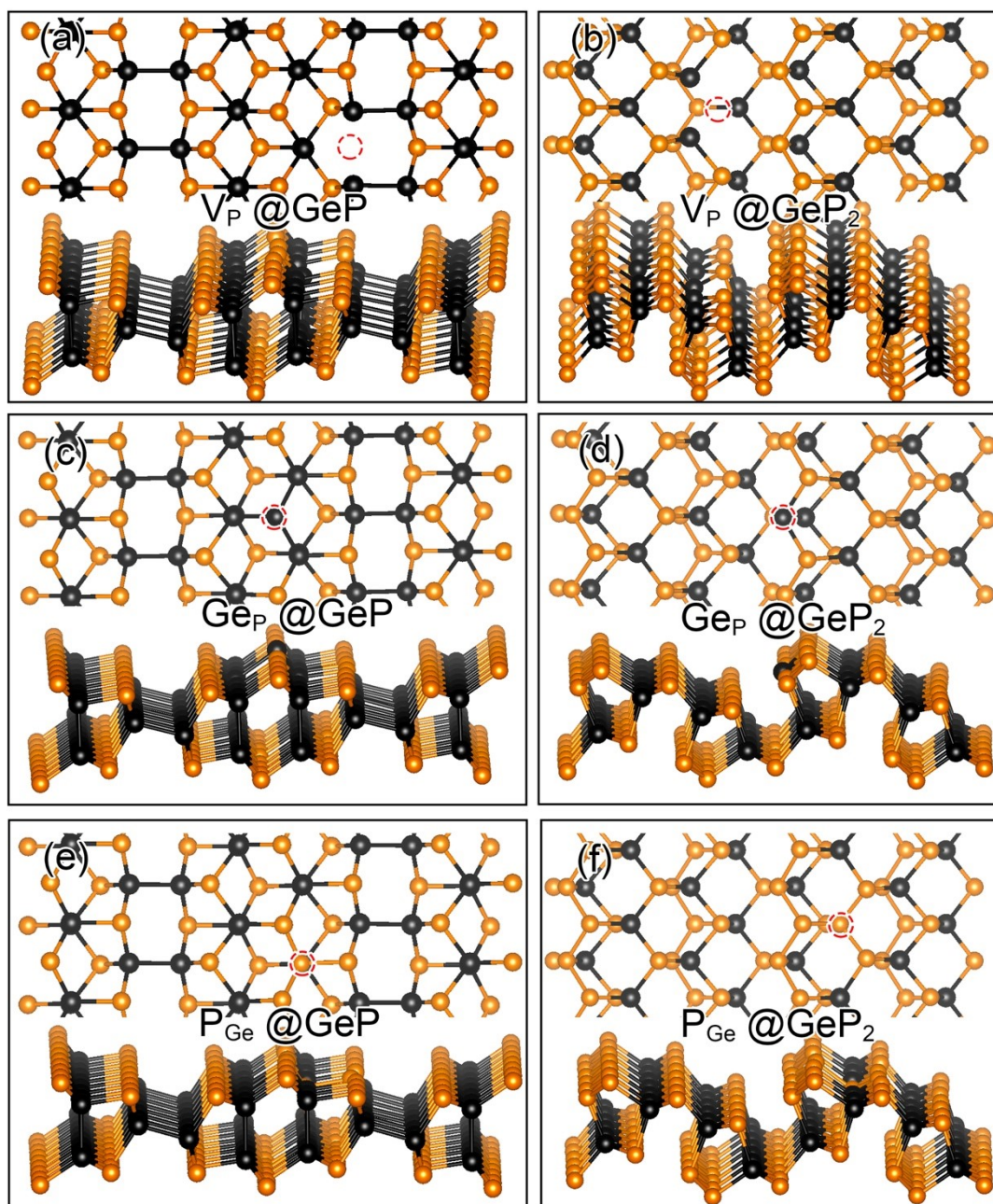


Figure S10. Atomic configurations of P vacancy (V_P) in (a) GeP and (b) GeP_2 , antisite Ge_P in (c) GeP and (d) GeP_2 , and antisite P_{Ge} in (e) GeP and (f) GeP_2 .

Table S3. Interlayer-spacing, thickness of each layer and relative total energies of pristine and defective GeP and GeP₂ under fixed-supercell and full relaxations.

		Interlayer-spacing (Å)		Thickness of each layer (Å)		Energy (eV)	
		Fixed-supercell	Full-relaxed	Fixed-supercell	Full-relaxed	Fixed-supercell	Full-relaxed
GeP	Pristine	1.46	1.46	6.44	6.44	0	0
	Ge _{P3}	1.46	1.44	6.44	6.40	0	-0.02
	P _{Ge2}	1.43	1.42	6.44	6.42	0	-0.00(07)
GeP ₂	Pristine	1.33	1.34	7.18	7.18	0	0
	Ge _{P2}	1.30	1.27	7.18	7.18	0	-0.04
	P _{Ge1}	1.33	1.32	7.18	7.19	0	-0.03

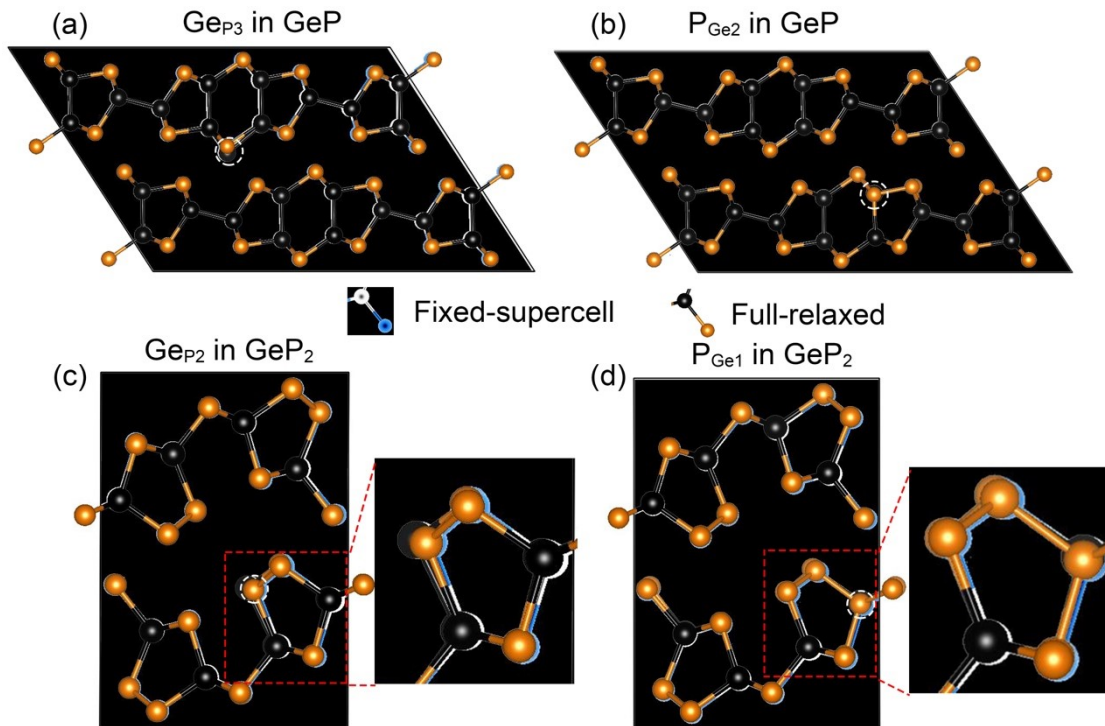


Figure S11. Comparison of relaxed structures with antisite defects under full-relaxed and fixed-supercell relaxed methods (white shadow indicating positions of atom under fixed-supercell relaxation).

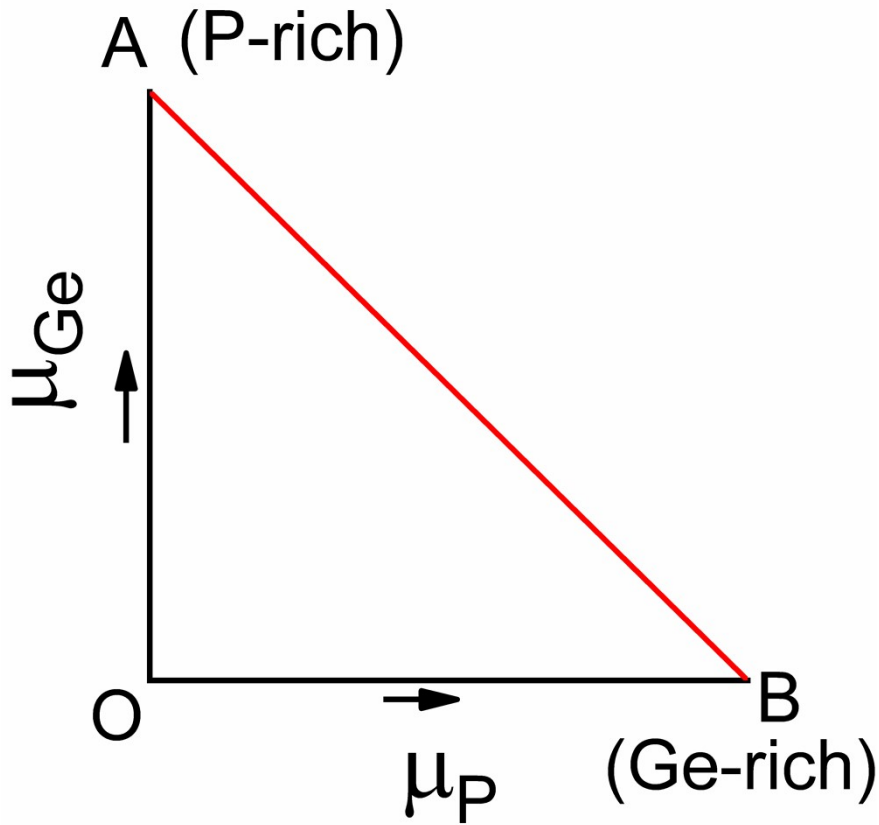


Figure S12. The chemical potential of host elements, μ_{Ge} and μ_{P} , satisfying the relation $\mu_{\text{Ge}} + \mu_{\text{P}} = \Delta H(\text{GeP})$, in the range of the red line AB. Point A (P-rich, bulk GeP: $\mu_{\text{Ge}} = -0.03$ eV and $\mu_{\text{P}} = 0$ eV, monolayer GeP: $\mu_{\text{Ge}} = -0.03$ eV and $\mu_{\text{P}} = 0$ eV) and point B (Ge-rich, bulk GeP: $\mu_{\text{Ge}} = 0$ eV and $\mu_{\text{P}} = -0.03$ eV, monolayer GeP: $\mu_{\text{Ge}} = 0$ eV and $\mu_{\text{P}} = -0.03$ eV), are boundaries of PBE calculated chemical potential range. For the HSE06 calculated chemical potential range, point A (P-rich condition, bulk GeP: $\mu_{\text{Ge}} = -0.058$ eV and $\mu_{\text{P}} = 0$ eV, 1L GeP: $\mu_{\text{Ge}} = -0.055$ eV and $\mu_{\text{P}} = 0$ eV) and point B (Ge-rich condition, bulk GeP: $\mu_{\text{Ge}} = 0$ eV and $\mu_{\text{P}} = -0.058$ eV, 1L GeP: $\mu_{\text{Ge}} = 0$ eV and $\mu_{\text{P}} = -0.055$ eV) are boundaries.

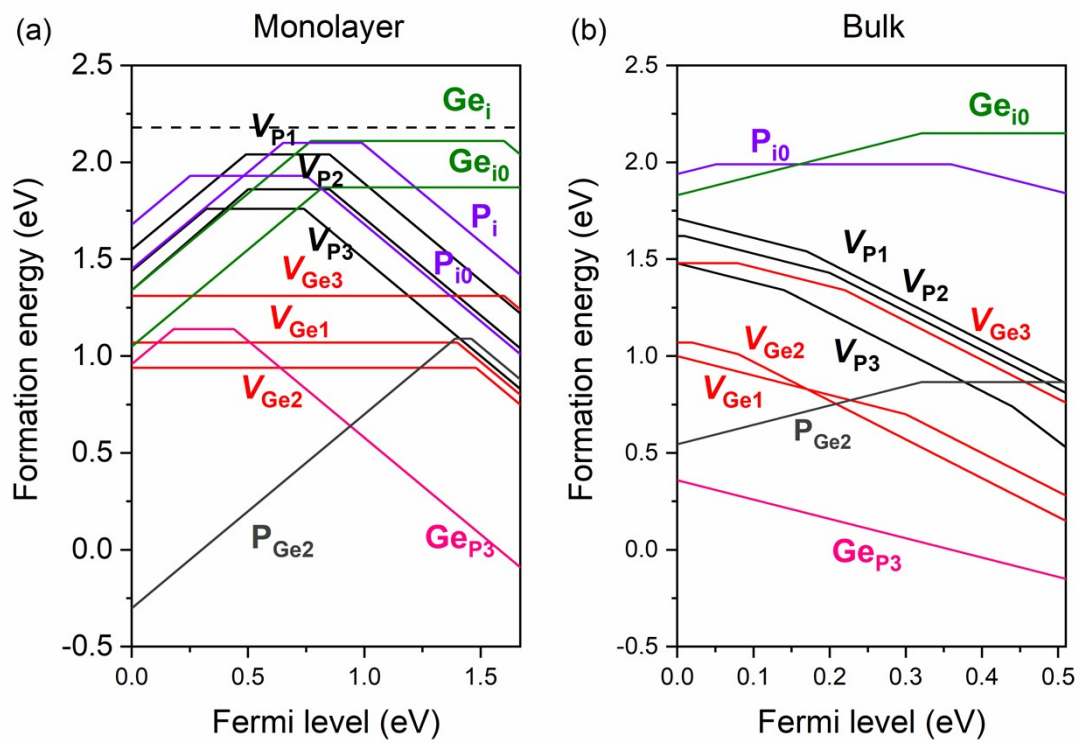


Figure S13. PBE calculated formation energy for all possible intrinsic defects in (a) monolayer GeP and (b) bulk GeP at Ge-rich condition.

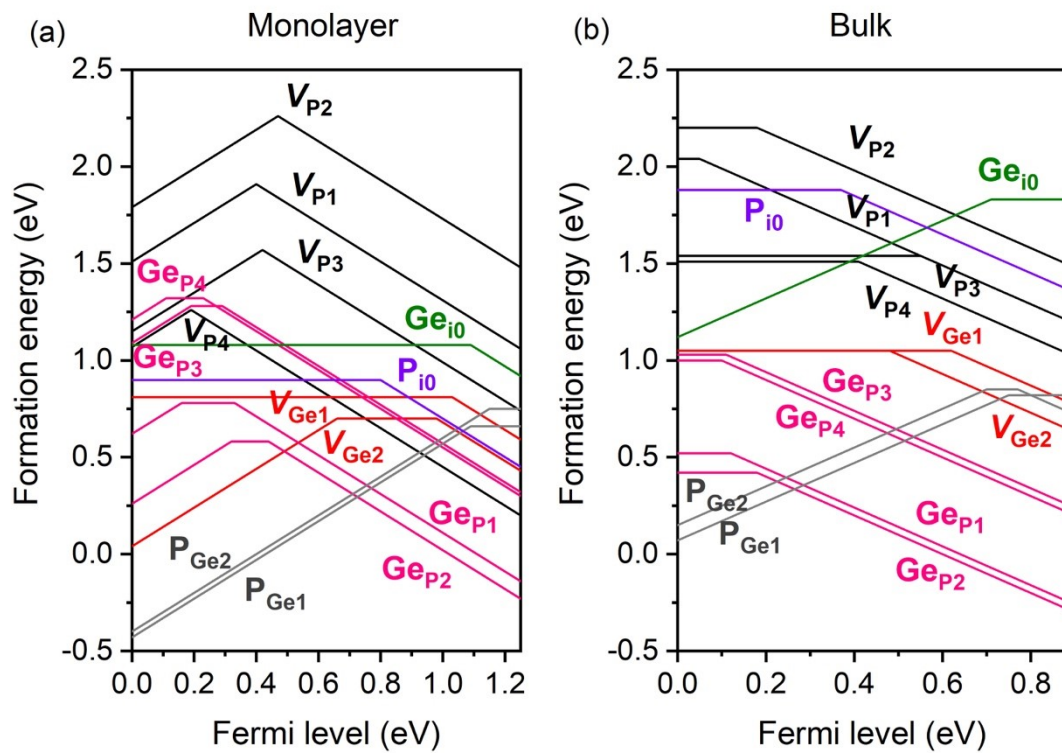


Figure S14. PBE calculated formation energy for all possible intrinsic defects in (a) monolayer GeP₂ and (b) bulk GeP₂ at Ge-rich condition.

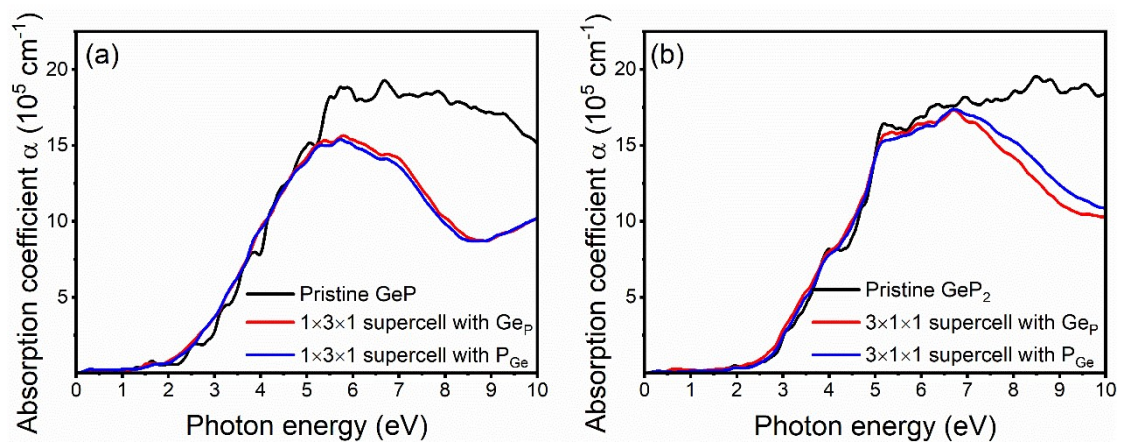


Figure S15. HSE06 calculated optical absorption coefficients of pristine and defective supercells (with antisites Ge_P and P_{Ge}) of (a) GeP and (b) GeP₂.

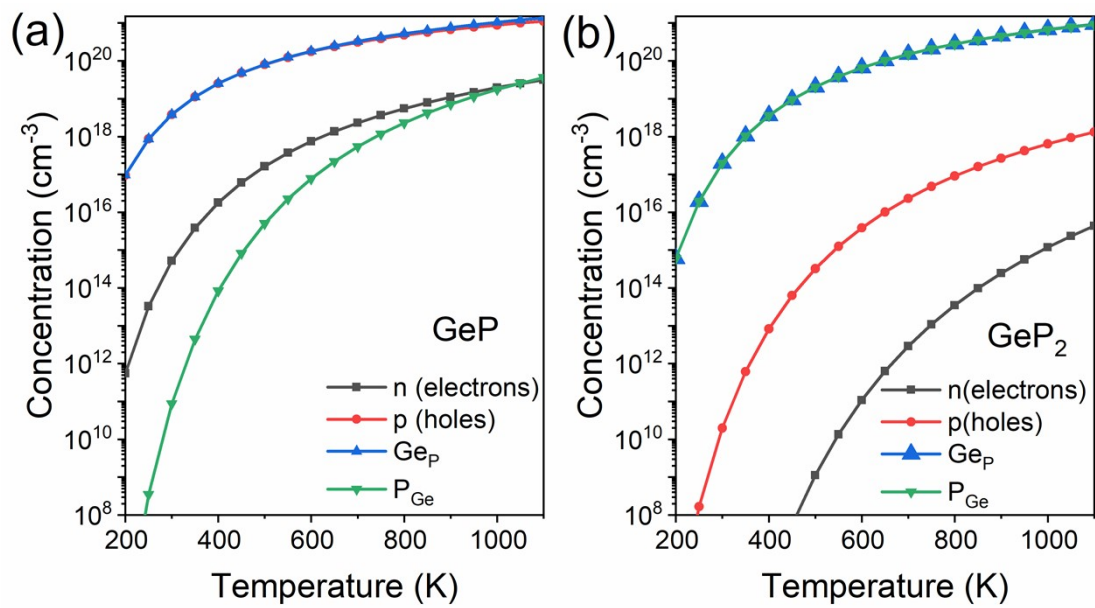


Figure S16. The carrier and defect concentrations as function of temperature for defects in bulk (a) GeP and (b) GeP₂.